Ferrom agnetism in (In,M n)AsD iluted M agnetic Sem iconductor Thin Films G rown by M etalorganic Vapor Phase Epitaxy

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 $In_{1 x} M n_x A s$ diluted m agnetic sem iconductor (DMS) thin Im s have been grown using m etalorganic vapor phase epitaxy (MOVPE). Tricarbonyl(m ethylcyclopentadienyl)m anganese was used as the Mn source. Nom inally single-phase, epitaxial Im s were achieved with Mn content as high as x = 0.14 using growth temperatures $T_g = 475$ C. For low er growth temperatures and higher Mn concentrations, nanom eter scale MnAs precipitates were detected within the $In_{1 x} M n_x A s m$ atrix. M agnetic properties of the Im s were investigated using a superconducting quantum interference device (SQUID) m agnetom eter. R com -temperature ferrom agnetic order was observed in a sam ple with x = 0.1. M agnetization m easurem ents indicated a Curie temperature of 333 K and a room tem perature saturation m agnetization of 49 em u/cm³. The rem nant m agnetization and the coercive eld were sm all, with values of 10 em u/cm³ and 400 0 e, respectively. A m echanism for this high-

tem perature ferrom agnetism is discussed in light of the recent theory based on the form ation of sm all clusters of a few m agnetic atom s.

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I. IN TRODUCTION

clustering at the atom ic level, will be discussed.

An approach to spin-sensitive devices for electronic applications, that may exhibit in proved spin injection, is the use of III-V diluted magnetic sem iconductors $(D M Ss)^{1/2}$ These alloys, which incorporate a small percentage of magnetic atoms into the sem iconductor host, have been shown to exhibit ferrom agnetic behavior up to 110 K ¹. However, for these materials to ndwidespread applications, the ferrom agnetism should be stable at room temperature. Consequently, much of the current experimental work is directed towards increasing their ferrom agnetic transition temperature, T_c . Since theory predicts that the transition temperature increases with the magnetic-ion concentration, e orts have centered on increasing such concentration.³ The solubility of magnetic ions, however, is often quite low.

III-V DMS have been grown using bw-temperature molecular beam epitaxy (LT-MBE) at temperatures lowerthan 300 C to prevent phase separation. Nevertheless, recently we have demonstrated the growth of single-phase, ferrom agnetic $In_{1 \ x} M n_x A s$, with x 0:14, using m etalorganic vapor phase epitaxy (MOVPE) at temperatures as high as 520 C.⁴ In this report, we present the results of our investigation of the magnetic properties of these lm s. We have observed room temperature ferrom agnetic behavior in a nom inally single-phase p-type $In_{0:9}M n_{0:1}A s$ lm. In contrast, a comparable high T_c has not been observed in single-phase (In,Mn)A s grown using LT-MBE. A possible mechanism for the observed high-temperature ferrom agnetism, based on transition metal

II. EPITAXY OF (In,M n)As

 $(In_{M}n)As$ In s were prepared using atmospheric pressure MOVPE, as described earlier.⁴ Films were grown at temperatures between 475{520 C on sem i-insulating GaAs(001) substrates. The precursors used were trimethylindium (TMIn), tricarbonyl(methylcyclopentadienyl)manganese (TCMn) and 0.3% arsine (AsH₃) in hydrogen. Phase composition was determined using double-crystalx-ray diraction (XRD) using Cu K₁ radiation. Energy dispersive x-ray spectroscopy (EDS) was used to determine the Mn concentration in the lms.

Figure 1 shows the -2 x-ray di raction pattern with the zinc-blende (004) and (002) re ections for a 300 nm thick $In_{0:9}Mn_{0:1}As$ Im grown at 520 C.No other peaks were observed, indicating that the alloy was phase pure to within 0.1 volume percent. The rocking-curve FW HM for this Im was 0.25. A zim uthal () scans for the f202g re ections of the Im and substrate were recorded to con Im epitaxy. Figure 2 shows the four-foldsym m etric di raction pattern for the f202g re ections of the (In M n)As Im com pared with that of the G aAs substrate. Excellent epitaxial alignment is observed despite the 7% lattice m ism atch between the Im and the substrate.

M nAs was observed in $\ln s$ grown at temperatures lower than 475 C and for M n concentrations greater than x = 0.14. G row that temperatures higher than

530 C resulted in very little deposition presum ably due to increased indium and manganese desorption from the surface.

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A. Magnetic eld dependence

The magnetic properties of the (In M n)A s thin Im s were measured using a SQUID magnetom eter. The magnetic eld was applied perpendicular to the plane of the Im along the easy axis of magnetization for $(In M n)A s.^5$ The substrate diamagnetic contribution was subtracted

from the totalm agnetization signal. The rem aining data consisted of the param agnetic and ferrom agnetic contributions from the lm. The totalm agnetization is given by:

 $M_{tot}(T; H) = M_{F}(T; H) + [p(T) + d(GaAs)]H$ (1)

where M $_{\rm F}$ (T;H) is the ferrom agnetic component of the lm, $_{\rm p}$ is the param agnetic susceptibility of the lm, $_{\rm d}$ is the substrate diam agnetic susceptibility, T is the tem – perature, and H is the applied magnetic eld. The magnetic response of a nom inally single-phase In_{0:9}M n_{0:1}As lm is shown in Figure 3 for applied magnetic elds up to 20 kO e and temperatures of 5, 150 and 300 K. The inset of Figure 3 shows the complete hysteresis loop for this sample at 5 K. At this temperature the measured saturation magnetization normalized to the lm volume was 62 em u/cm³ with a remanence of 10 em u/cm³ and a coercive eld of 400 O e. When the temperature was increased to 300 K, the saturation magnetization decreased only to 49 em u/cm³.

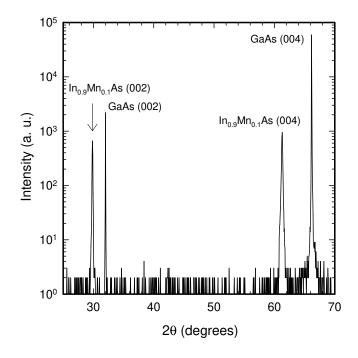


FIG. 1: -2 x-ray diraction scan of $In_{0.9}M n_{0.1}A s/G aA s(001)$ showing the respective (002) and (004) re ections. No evidence of M nAs second phase was observed.

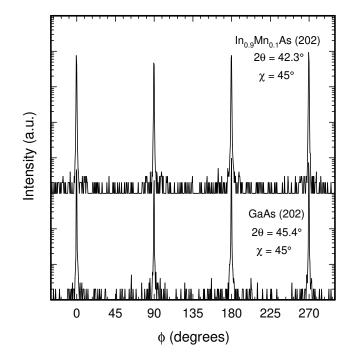


FIG.2: A zim uthal, , x-ray di raction scans for the f202g re ections of $In_{0.9}M n_{0.1}As$ and GaAs indicating the degree of epitaxy with the GaAs substrate. The angle of the f202g di racting planes with respect to the sam ple surface is = 45.

B. Tem perature dependence

The magnetization as a function of temperature was measured for the single-phase $In_{0:9}Mn_{0:1}As$ sample discussed above. The sample was zero-eld cooled and then subjected to a 10 kO e applied magnetic eld perpendicular to the plane of the Im. A fter subtraction of the diam agnetic substrate contribution, the resulting magnetization is shown in Figure 4.

A Curie tem perature of 333 K was measured for this sam ple. Such a high Curie tem perature for a III-V dilute magnetic sem iconductor has been previously attributed to the presence of M nAs⁶ which has a Curie tem perature of 318 K . However, the presence of M nAs was not observed by x-ray di raction in this sample as shown in Figure 1. If a second phase were present, the measured magnetization of 62 emu/cm³ would correspond to a M nAs volum e fraction of approxim ately 10%. This should certainly be observable by x-ray di raction. If on the other hand the M nAs was present as nanoprecipitates, the magnetization would be considerably smaller as observed in (Ga, Mn)As lm s.⁷ Thus the magnetization data is consistent with the alloy Im being a single-phase. Currently, we are investigating precipitate form ation further through transm ission electron m icroscopic analysis.

The value of the saturation magnetization of $(In_{M}n)As$ is given by $M_{s} = N_{Mn}g_{B}J_{Mn}$, where N_{Mn} is the nom inal concentration of M n ions, g is the Landee

factor and is equal to 2 for M n, $_{\rm B}$ is the Bohrm agneton, and $J_{\rm M~n}$ is the spin of M n. The measured M $_{\rm S}$ using x = 0:1, corresponding to N $_{\rm M~n}$ =1.8 10^{21} cm 3 , gives a value of = 3:6 $_{\rm B}$. This corresponds to a value of $J_{\rm M~n}$ between 4/2 and 3/2. This is interpreted as an indication of the presence of valence states other than M n²⁺.

The tem perature dependence of the magnetization was compared to the Brillouin function for dierent values of the total angular momentum, J. The lack of agreement between the Brillouin function and the measured data above 150 K indicates that the transition to the ferromagnetic state may not be second order, in which the change in magnetization value is continuous with increasing tem perature. It may be rst order.

M agnetic disordering as a rst order phase transform ation has previously been reported and a model to describe this behavior was developed by B ean and R odbell.⁹ The model predicts that if the exchange interaction is a strong function of the inter-atom ic spacing and the lattice is compressible, then the ferrom agnetic to param – agnetic transition will be rst-order. By introducing a strain energy term into the free energy formulation and m inim izing with respect to the reduced m agnetization, it was show n⁹ that the tem perature dependence of the m agnetization for J = 1=2 is given by

$$T = T_o = (tanh^1)(1 + {}^2 = 3 PK)$$
 (2)

where 3=2N kK T_c², is the reduced m agnetization (norm alized to the saturation m agnetization), N is the

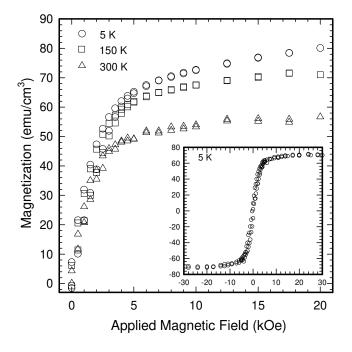


FIG.3: M agnetization as a function of applied m agnetic eld for a $In_{0:9}M n_{0:1}A$ s sam ple (A JB 070) m easured at 5, 150, and 300 K . M agnetic eld was applied perpendicular to the plane of the Im. Inset is the com plete hysteresis loop at 5 K.

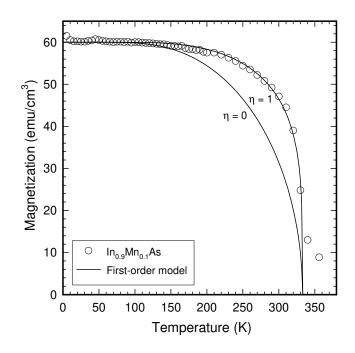


FIG. 4: Tem perature dependence of the magnetization for the $In_{0:9}M n_{0:1}A s$ sample (AJB070) compared with the model of Bean and Rodbell for J = 1=2 and P = 0.9^{9} M agnetic eld strength was 10 kO e an was applied perpendicular to the plane of the $Im . A T_c = 333$ K and M $_s = 60$ em u/cm 3 were used for the tting.

num ber of m agnetic dipoles per unit volume, k is the Boltzm ann constant, K is the compressibility, is the slope of the dependence of T_c on volume, and T_o is the C unie temperature if the lattice were not compressible. P and T are the pressure and temperature respectively.

For < 1, the transition is second order, and Equation 2 reduces to the B rillouin function for = 0. For > 1, the transition is rst order and the magnetization exhibits a discontinuity at the transition temperature. The measured magnetization was compared with the model of Bean and Rodbell for di erent values of as shown in Figure 4. As can be seen, the best t occurred for = 1. This indicates that the phase transform ation for the alloy has an interm ediate character between rst and second order.

A deviation between theory and experiment at temperatures above the Curie temperature was also observed. This was addressed in the initial work by Bean and Rodbell and is a consequence of the long-range interaction implicit in the model.⁹ Molecular eld theory which was used in the model, indicates no order above the Curie temperature for a norm al ferrom agnet. Experimentally, how ever, signi cant short-range order can be observed.

For comparison, the ferrom agnetic to param agnetic phase transition of M nAs has been shown to be rstorder^{9,10,11} with a value of = 2.9 W e have measured the tem perature dependence of the magnetization for an (In M n)As sample which exhibited M nAs phase form a-

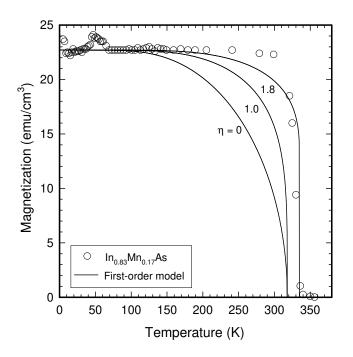


FIG.5: Tem perature dependence of the m agnetization for a two phase sam ple ($In_{0:83}M n_{0:17}A s + M nA s$) (AJB076) com – pared with the m odel of Bean and R odbell for J = 1=2 and P = 0. M agnetic eld strength was 1 kO e and was applied perpendicular to the plane of the Im. A T_c = 318 K and M _s = 23 em u/cm³ were used for tting.

tion. The magnetization is shown in Figure 5 as a function of temperature. In this case the temperature dependence appears to be clearly rst-order. Fitting of the magnetization data using the rst-order model resulted in a value of = 1.8. Thus it can be seen that the temperature dependence of the magnetization for (In M n)A s/M nA s two phase alloys di ers from that of (In M n)A s single-phase alloys. The temperature dependent magnetization of In_{0:9}M n_{0:1}A s sam ple shown in Figure 4 is closer to second-order and cannot sim ply be explained by the presence of M nA s nanoprecipitates.

C. Origin of Ferrom agnetism

The ferrom agnetism observed in III-V DMS lms has been previously explained within the fram ework of sp-d exchange interactions between the Ferm i sea and the localized m agnetic m om ents.¹² Sim ilar to RKKY theory, this hole-m ediated ferrom agnetism theory predicts that the C urie tem perature is dependent upon both m agnetic ion concentration and hole concentration. U sing this m odelD ietlet al. predicted that the transition tem pera-

ture for (In,Mn)Aswith a Mn concentration of 5% should be 35 K , which is much lower than that observed in the present study. One possible explanation for the di erence is that M n in the alloy is not random ly distributed on In sites but is present as atom ic clusters. This is supported by the recent calculations of van Schilfgaarde and M ryasov based on local density functional theory.¹³ These calculations predict that due to the strong attractive coupling between the M n ions and the sem iconductor cation nuclei, there is a large driving force for the form ation of M n clusters consisting of two or more M n atom s located at nearest-neighbor cation sites.¹⁹ These atom ic clusters in turn can stabilize the ferrom agnetic state; according to this model, the presence of free carriers is not required. A lthough the model does not consider kinetice ects, which may determ ine whether Mn clustering occurs, the growth tem perature used for our Ims is likely su cient to overcom e any kinetic barrier to cluster form ation. Indeed clustering of the transition-m etal ion has been observed in other III-V DM Ss grown at high tem peratures^{14,15,16} and may also occur in other materials that have been shown to exhibit ferrom agnetic behavior while having n-type conductivity.^{17,18} P resently, we are pursuing extended x-ray absorption ne structure (EXAFS) measurements of these Ims to determ ine the local environm ent of M n.

IV. CONCLUSIONS

In conclusion, epitaxial, single-phase $In_{0:9}Mn_{0:1}As$ Im s have been grown using metalorganic vapor phase epitaxy at temperatures as high as 520 C. Temperatureand eld-dependent magnetization measurements indicated a single-phase Im (as measured by x-ray di raction) to be ferrom agnetic with a Curie temperature of 333 K. M odelling of the magnetization data indicated that the ferrom agnetic-to-paramagnetic phase transition was intermediate between rst and second order. The origin of the observed ferrom agnetism was discussed in the light of a new theory based on the form ation of transitionmetal clusters.

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¹ H.Ohno, Science 281, 951 (1998).

² T.Dietl, H.Ohno, F.Matsukura, J.Cibert, and D.Fer-

rand, Science 287, 1019 (2000).

- ³ H.Ohno, Physica E 6, 702 (2000).
- ⁴ A.J.Blattner, J.Lensch, and B.W. Wessels, J.Electron. M ater. 30, 1408 (2001).
- ⁵ H.M unekata, A.Zaslavsky, P.Fum agalli, and R.J.Gam bino, Appl. Phys. Lett. 63, 2929 (1993).
- ⁶ S. von Molnar, H. Munekata, H. Ohno, and L. Chang, J. Magn. Magn. Mater. 93, 356 (1991).
- ⁷ J. D. Boeck, R. Oesterholt, A. V. Esch, H. Bender, C. Bruynseraede, C. V. Hoof, and G. Borghs, Appl. Phys. Lett. 68, 2744 (1996).
- ⁸ H.Ohno, H.M unekata, S.von Molhar, and L.L.Chang, J.Appl.Phys. 69, 6103 (1991).
- ⁹ C.P.Bean and D.S.Rodbell, Phys. Rev. 126, 104 (1962).
- ¹⁰ V.A.Chemenko, L.W ee, P.G.M cCommick, and R.Street, J.Appl.Phys.85, 7833 (1999).
- ¹¹ L.Pytlik and A.Zieba, J.Magn.Magn.Mater. 51, 199 (1985).
- ¹² T.Dietl, H.Ohno, and F.M atsukura, Phys. Rev. B 63, 195205 (2001).

- ¹³ M. van Schilfgaarde and O. N. M ryasov, Phys. Rev. B 63, 233205 (2001).
- ¹⁴ S.Haneda, M.Yamaura, Y.Takatani, K.Hara, S.I.Harigae, and H.Munekata, Jpn.J.Appl.Phys. 39, L9 (2000).
- ¹⁵ Y.L.Soo, G.K ioseoglou, S.H uang, S.K im, Y.H.K ao, Y.Takatani, S.H aneda, and H.M unekata, Phys. Rev. B 63, 195209 (2001).
- ¹⁶ Y.L.Soo, G.Kioseoglou, S.Kim, S.Huang, Y.H.Kao, S.Kuwabara, S.Owa, T.Kondo, and H.Munekata, Appl. Phys.Lett. 79, 3926 (2001).
- ¹⁷ M.L.Reed, N.A.ELM asry, H.H. Stadelm aier, M.K. Ritum s, M.J.Reed, C.A.Parker, J.C.Roberts, and S.M.Bedair, Appl. Phys. Lett. 79, 3473 (2001).
- ¹⁸ M.E.Overberg, C.R.Abernathy, S.J.Pearton, N.A. Theodoropoulou, K.T.McCarthy, and A.F.Hebard, Appl.Phys.Lett. 79, 1312 (2001).
- ¹⁹ M n substitutes on the In sublattice form ing clusters containing 2 or 3 M n atom s. For m agnetic \dim ers", the M n atom s are located at nearest-neighbor cation sites as in Ref. 13.